

Notice of References Cited		Application/Control No. 09/821,298	Applicant(s)/Patent Under Reexamination YAMANAKA ET AL.	
		Examiner Cong-Lac Huynh	Art Unit 2178	Page 1 of 1

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NON-PATENT DOCUMENTS

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	U	Chawathe et al., Meaningful Change Detection in Structured Data, ACM 1997, pages 26-37.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.